Se	arch	Note:	S

Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,486	CLINTON ET AL.
Examiner	Art Unit
Oanh Duong	2155

	SEAR	CHED	
Class	Subclass	Date	Examiner
709	203, 223, 224, 221, 229	10/11/2006	O.D
725	25,26	10/11/2006	O.D
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
EAST text search of USPAT, JPO, EPO, DERWENT, IBM_TDB, USPGPUB	10/11/2006	O.D
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